

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10711933	WU ET AL.
	Examiner	Art Unit
	HENOK G HEYI	2627

SEARCHED

Class	Subclass	Date	Examiner
369	30.1 - 30.18	05/22/2008	Henok Heyi
369	44.27 - 44.35	05/22/2008	Henok Heyi
369	53.24	05/22/2008	Henok Heyi
369	53.37	05/22/2008	Henok Heyi

SEARCH NOTES

Search Notes	Date	Examiner
Updated search and consulted with primary Tan Dinh.	05/22/2008	Henok Heyi

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner